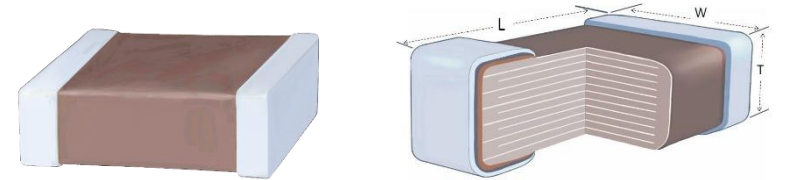


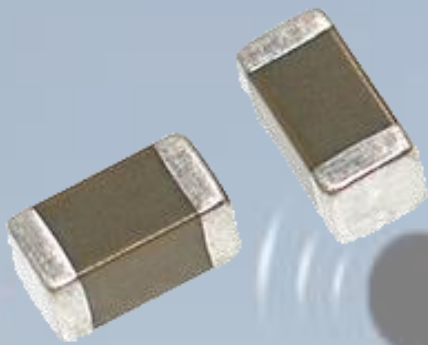
Multilayer Ceramic Chip Capacitors

江苏芯声电子科技有限公司

Jiangsu Holy Ram Electronics
Technology Limited



CIA 系列 (工规等级, Industrial Grade)



材质	X7R	X5R	C0G	X6S
温度范围	-55°C--125°C	-55°C--85°C	-55°C--125°C	-55°C--105°C
容值变化率	±15%	±15%	±30ppm/°C	±22%

PRECAUTIONS FOR USE

Plz attach the purchase specification before using this product.

SAFETY INFORMATION

Plz pay attention to safety precautions when using this product.

Limitation of Applications

Plz contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

- ①Aircraft equipment ②Aerospace equipment ③Undersea equipment ④Power plant control equipment
- ⑤Medical equipment ⑥Transportation equipment(vehicles,trains,ships,etc.) ⑦Traffic signal equipment
- ⑧Disaster prevention / crime prevention equipment ⑨Data-processing equipment ⑩Application of similar complexity and/or reliability requirements to the applications listed in the above

Methods of transportation and storage

1.Transportation:

Packaged products suitable for modern transportation, in the process of transportation to prevent rain and acid and alkali corrosion, gravity throwing and force extrusion.

2.Storage:

The storage period to ensure good weldability of the product is one year from the date of production. Do not open the braid before use of the product (in the case of packaging and delivery). After the braid is opened, the product should be used within three months.

storage temperature: 0°C~35°C

Storage relative humidity:<70%

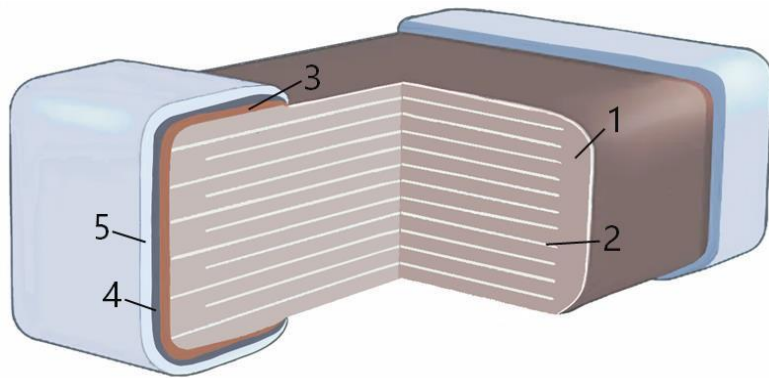
Characteristic

Conventional capacitors can be divided into temperature compensation type (Class I) and high dielectric constant type (Class II) according to material characteristics.

Temperature compensation type: This kind of material capacitor has high stability to temperature, the best stability under different voltage and temperature, and its loss is the least. Its temperature coefficient is 30 ppm/°C, suitable for low loss, high stability requirements of the circuit, such as filters, resonators and timing circuits, common C0G series.

High dielectric constant type: capacitors of this kind of dielectric material have higher dielectric constant and higher capacity than those of temperature compensation type, but their accuracy and stability are poor. Between -55°C and 85°C (125 °C) temperature range, capacitance error value will be within 15%, suitable for a wide range of capacity of the circuit, such as straight, coupling, bypass circuit, common X5R, X7R, X6S series.

Product Structure Diagram



Serial number	Designation
1	Dielectric ceramics
2	Inner electrode (nickel)
3	Outer electrode (copper)
4	Nickel layer
5	Tin layer

Application

Base station, manufacturing equipment, industrial robot equipment, measuring equipment and other industrial equipment

产品型号命名规则

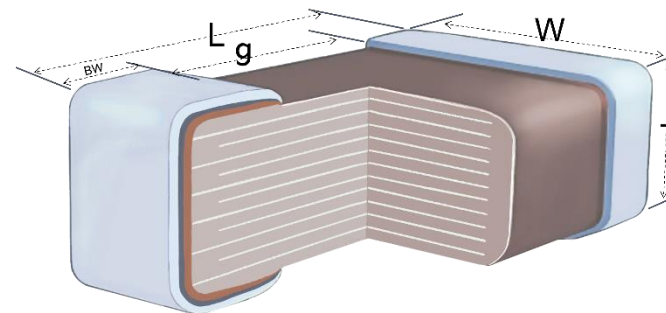
EX: C IA 0402 X7R 104 K 500 G T
 (1) (2) (3) (4) (5) (6) (7) (8) (9)

(1)	C:MLCC			(5) Capacitance Value	Cap. > =10pF: First Two×10 ^{third} 104=10×10 ⁴ =100nF 123=12×10 ³ =12nF Cap. < 10pF: R30=0.3pF, 1R0=1pF													
(2) Application	IA:Industrial				(6) Capacitance Tolerance	A: ±0.05pF		B: ±0.1pF		C: ±0.25pF		D: ±0.5pF		F: ±1.0%				
(3) Product size (L*W)	Coding	inch	mm	(7) Rate Voltage Vdc		G: ±2%		J: ±5%		K: ±10%		M: ±20%		Z: 80/-20%				
	00R4	008004	0201		2R5:2.5		4R0:4.0		6R3:6.3		100:10		160:16		250:25			
	01R5	01005	0402		350:35		500:50		630:63		800:80		101:100		201:200			
	0201	0201	0603		251:250		401:400		451:450		501:500		631:630		102:1000			
	0402	0402	1005		202:2000		252:2500		302:3000		402:4000							
	0603	0603	1608		(8) Thickness (mm)		A:0.10		B:0.13		C:0.18		D:0.20		E:0.30		F:0.45	
	0805	0805	2012		G:0.50		H:0.60		J:0.80		K:0.85		L:1.15		M:1.25			
	1206	1206	3216		N:1.60		P:1.90		Q:2.00		R:2.50							
	1210	1210	3225		(9) Packing		T: Finished product packaging (7" Reel)											
1808	1808	4520																
1812	1812	4532																
(4) Temperature characteristic	X5R X6S X7R X7S C0G																	

Size & Packing Specifications

Generally, a $\Phi 180\text{mm}$ (7") tray is used for packing.

Each 5 disks is packed into a box, and each 12 boxes is a whole box.



Specification	Size (mm)				Packing (7")		
	Length	Width	Thickness	g	Number(piece)	Method	
0201	0.60 ± 0.03	0.30 ± 0.03	0.30 ± 0.03	0.20	15,000	Paper tape	
	$0.60+0.10/-0.03$	$0.30+0.10/-0.03$	$0.30+0.10/-0.03$				
0402	1.00 ± 0.10	0.50 ± 0.10	0.50 ± 0.10	0.30	10,000	Paper tape	
	$1.00+0.20/-0.05$	$0.50+0.20/-0.05$	$0.50+0.20/-0.05$				
0603	1.60 ± 0.10	0.80 ± 0.10	0.80 ± 0.10	0.60	4,000	Paper tape	
	1.60 ± 0.20	0.80 ± 0.20	0.80 ± 0.20				
0805	2.00 ± 0.10	1.25 ± 0.10	0.60 ± 0.10	0.70	4,000	Paper tape	
			0.85 ± 0.10				
	2.00 ± 0.20	1.25 ± 0.20	1.25 ± 0.20				2,000
1206	3.20 ± 0.20	1.60 ± 0.20	0.85 ± 0.10	1.50	4,000	Paper tape	
			1.25 ± 0.20				
			1.60 ± 0.20				
	3.20 ± 0.30	1.60 ± 0.30	1.60 ± 0.30				2,000
1210	3.20 ± 0.30	2.50 ± 0.20	1.25 ± 0.20	1.50	2,000	Paper tape	
			1.60 ± 0.20				
			2.00 ± 0.20				
			2.50 ± 0.30				2.50 ± 0.30
	3.20 ± 0.40	2.50 ± 0.30	2.50 ± 0.30				2,000

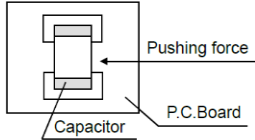
【X7R】 0201~1210

尺寸 (inch)	电压 (Vdc)	100pF						1nF						10nF						100nF						1uF			10uF			100uF			容值范围
		101	151	221	331	471	681	102	152	222	332	472	682	103	153	223	333	393	473	683	104	154	224	334	474	684	105	225	475	106	226	476	107	227	
0201	10																																	10nF~10nF	
	16																																	1nF~10nF	
	25																																	680pF~1.0nF	
0402	6.3																																220nF~1.0uF		
	10																																33nF~220nF		
	16																																1.0nF~220nF		
	25																																1.0nF~220nF		
0603	50																																220pF~100nF		
	10																																220nF~1.0uF		
	16																																100nF~1.0uF		
	25																																39nF~1.0uF		
	50																																680pF~220nF		
0805	100																																1.0nF~100nF		
	6.3																																10uF~10uF		
	10																																2.2uF~10uF		
	16																																2.2uF~4.7uF		
	25																																100nF~4.7uF		
	50																																1.0nF~2.2uF		
1206	100																																10nF~10nF		
	6.3																																22uF~22uF		
	10																																22uF~22uF		
	16																																1uF~2.2uF		
	25																																1uF~2.2uF		
	50																																100nF~2.2uF		
	100																																2.2uF~2.2uF		
1210	630																																10nF~10nF		
	50																																4.7uF~10uF		
	100																																4.7uF~4.7uF		
1210	630																																47nF~47nF		

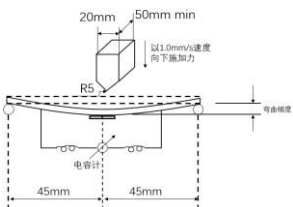
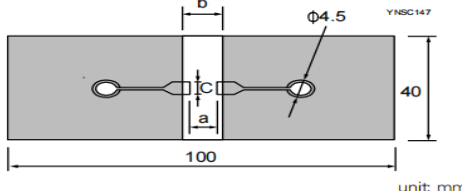
Specifications and Test Methods

No	Item	Specification	Test Method(Ref. Standard:JIS C 5101, IEC60384)			
1	Appearance	No defects or abnormalities.	Visual inspection			
2	Dimension	Shown in Dimension.	Using Measuring instrument of dimension.			
3	Voltage proof	Withstand the test voltage No defects or abnormalities.	Material	Rate voltage(RV)		Test voltage
			COG	RV≤50V		300% RV
				50V < RV≤250V		200% RV
				250V < RV≤500V		150% RV
				500V < RV≤1000V		130% RV
			X7R/X5R/X6S	RV≤50V		250% RV
				50V < RV≤250V		200% RV
				250V < RV≤630V		150% RV
630V < RV≤1000V		120% RV				
Applied Time			Applied Time			
Charge/discharge current			50mA MAX			
4	Insulation Resistance (I.R.)	Plz refer to the single specification	Test Temperature			Test Temperature
			Test Point			Test Point
			Test Voltage			Test Voltage
			Charging Time			Charging Time
			Charge/discharge current			Charge/discharge
5	Capacitance	Within the specified tolerance	Measurement Temperature			Measurement
			Material	Material	Material	Material
				C≤1000pF	1.0±0.1MHz	1.0±0.2Vrms
6	Q or Dissipation Factor (D.F.)	Plz refer to the single specification	COG	1000pF < C≤10uF	1.0±0.1KHz	1.0±0.2Vrms
				C > 10uF	120Hz±24Hz	0.5V±0.1Vrms
			X7R/X5R/X6	X7R/X5R/X6S	X7R/X5R/X6S	X7R/X5R/X6S

Specifications and Test Methods

No	Item	Specification	Test Method(Ref. Standard:JIS C 5101, IEC60384)		
7	Temperature Characteristics of Capacitance	Material	The capacitance change should be measured after 5 min at each specified temp. stage. After reaching thermal equilibrium at each step, measure		
		Cap. Change			
		C0G	Within $\pm 30\text{ppm}/^\circ\text{C}$	Step	Temperature($^\circ\text{C}$)
		X5R	$\pm 15\%$	1	Reference Temp.: $25\pm 2^\circ\text{C}$
		X6S	$\pm 22\%$	2	Min.Operating Temp.: $\pm 3^\circ\text{C}$
				3	Reference Temp.: $25\pm 2^\circ\text{C}$
		X7R	$\pm 15\%$	4	Max.Operating Temp.: $\pm 2^\circ\text{C}$
5	Reference Temp.: $25\pm 2^\circ\text{C}$				
8	Adhesive Strength of Termination	No removal of the terminations or other defect should occur.	Mounting	Solder the capacitor on the test substrate	
			Applied Force	5N (0402:2.5N / 0201:1N)	
			Holding Time	$10\pm 1\text{s}$	
			Applied Direction	Thrust is gradually applied in the center of the specimen along the horizontal direction of the P.C. plate. 	

Specifications and Test Methods

No	Item	Specification	Test Method(Ref. Standard:JIS C 5101, IEC60384)			
9	Substrate Bending test	Appearance:No defects or abnormalities.	Mounting method	Reflow solder the capacitor on the test substrate and bend 1mm		
		$\Delta C/C$ < Universal series > X7R/X5R: $\pm 10\%$ C0G: $\pm 1\%$ or 0.5 pF <High capacitance> (Whichever is larger) X7R/X5R: $\pm 12.5\%$	 			
10	Solderability	95% of the terminations is to be soldered evenly and continuously.	Kind of Solder:Sn-3.0Ag-0.5Cu(Lead Free Solder)			
			scaling powder :Isopropyl alcohol Rosin 25% solid solution.			
			Test Temperature:245 \pm 5 $^{\circ}$ C			
			Test Time :2 \pm 0.5s.			
			Solder position: Until both ends are completely wet			
11	Resistance to Soldering Heat	Appearance	No defects or abnormalities.	Pre-treatment	Heat treatment:Perform a heat treatment at 150+0/-10 $^{\circ}$ C for 1hour and then let sit for 24+/-2hours at room temperature, then measure.	
		Capacitance	Materia	Cap. Change	Test Method	Solder bath method
			C0G	Plz refer to the single specification	Kind of Solder	Sn-3.0Ag-0.5Cu(Lead Free Solder)
			X7R/X5		Test Temperature	260 \pm 5 $^{\circ}$ C
		Q or D.F.	Within the specified initial value.	Test Time	10 \pm 1s	
		I.R.	Within the specified initial value.	Preheat Temperature	110 $^{\circ}$ C to 140 $^{\circ}$ C	
		Voltage proof	No defects or abnormalities.	Preheat Time	1min	
Post-treatment	Non treatment:Let sit for 24+/-2hours at room temperature, then measure.					

Specifications and Test Methods

No	Item	Specification	Test Method(Ref. Standard:JIS C 5101, IEC60384)						
12	Temperature Cycle	Appearance	No defects or abnormalities.	Mounting method	Solder the capacitor on the test substrate				
				Pre-treatment	Heat treatment:Perform a heat treatment at 150+0/-10°C for 1hour and then let sit for 24+/-2hours at room temperature, then measure.				
		Capacitance	Material	Cap. Change	Temperature Cycles	COG & X7R—100cycles X5R & X6S—5cycles			
			COG	Plz refer to the single specification	Step	Temperature(°C)	Time(min)		
		X7R/X5R/X6S	1		Min Operating Temp.:±3°C	30±3min			
		Q or D.F.	Within the specified initial value.	2	3	Room Temp.	2~5min		
					3	Max Operating Temp.:±3°C	30±3min		
I.R.	Within the specified initial value.	4	4	Room Temp.	2~5min				
			Post-treatment	Non treatment:Let sit for 24+/-2hours at room temperature, then measure.					
13	High Temperature High Humidity	Appearance	No defects or abnormalities.	Mounting method	Solder the capacitor on the test substrate				
				Pre-treatment	Heat treatment:Perform a heat treatment at 150+0/-10°C for 1hour and then let sit for 24+/-2hours at room temperature, then measure.				
		Capacitance	Material		Cap. Change	Test Temperature	40±2°C		
				Test Humidity		90%RH to 95%RH			
		Q or D.F. (COG)	Capacitance	Q	Test Time	500±24h			
					C ≥ 30pF	Plz refer to the single specification	Test Voltage	Rate Voltage (Not more than 630V)	
							10pF < C < 30pF	Charge/discharge current	50mA max
					< 10pF				Voltage regulation "After voltage treatment of the capacitor at test temperature and voltage for 1 hour", place the electrical vessel under ambient conditions for 24±2 hours prior to measurement, using this measurement as the initial value.
		Q or D.F. (X7R/X5R/X6S)	Plz refer to the single specification						
		I.R.	Plz refer to the single specification						

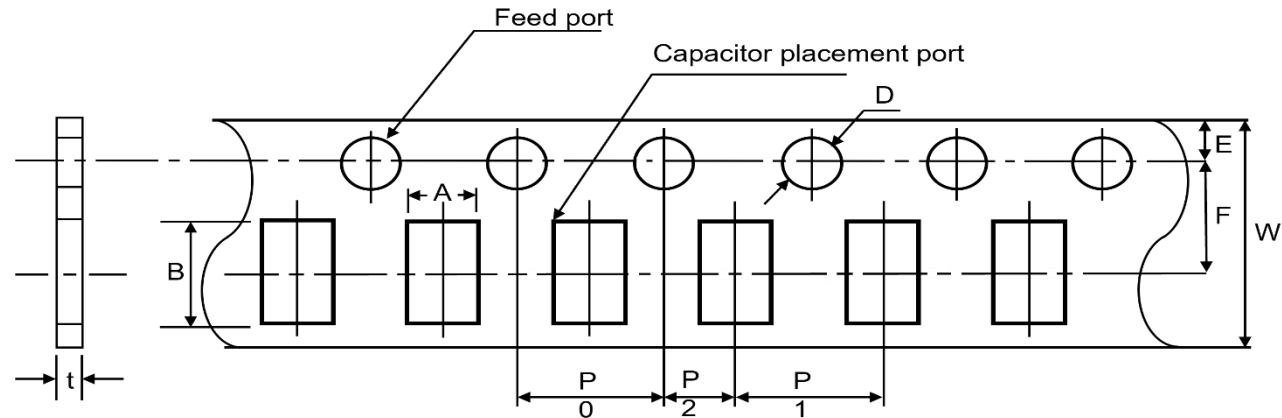
Specifications and Test Methods

No	Item	Specification	Test Method(Ref. Standard:JIS C 5101, IEC60384)			
14	Life	Appearance	No defects or	Mounting method	Solder the capacitor on the test	
		Capacitance	Material	Cap.Change	Pre-treatment	Voltage treatment:Apply the test voltage at the test temperature for 1 hour and then let sit for 24+/-2hours at room temperature, then measure.
				Plz refer to the single specification	Test Temperature	Max. Operating Temp.:±3°C
					Test Time	1000±12 h
		Q or D.F. (COG)	Capacitance	Q	Test Voltage (life)	Plz refer to the single specification
			C≥30pF	Plz refer to the single specification	Charge/discharge current	50mA max
			10pF < C < 30pF		Voltage regulation "After voltage treatment of the capacitor at test temperature and voltage for 1 hour", place the electrical vessel under ambient conditions for 24±2 hours prior to measurement, using this measurement as the initial value.	
			< 10pF			
		Q or D.F. (X7R/X5R/X6S)	Plz refer to the single specification			
		I.R.	Plz refer to the single specification			

Product Packaging

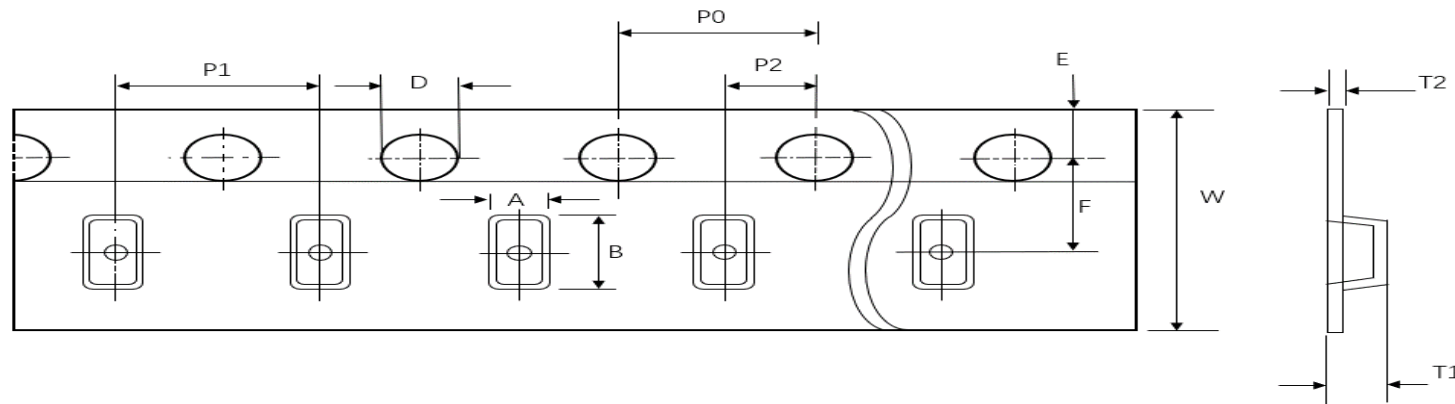
At present, the most common way of packaging is to carry coil packaging. A coil with a diameter of 180mm (7") can contain 1000~20000 capacitors, or coil packaging can be carried out according to customer requirements.

1. Tape Size



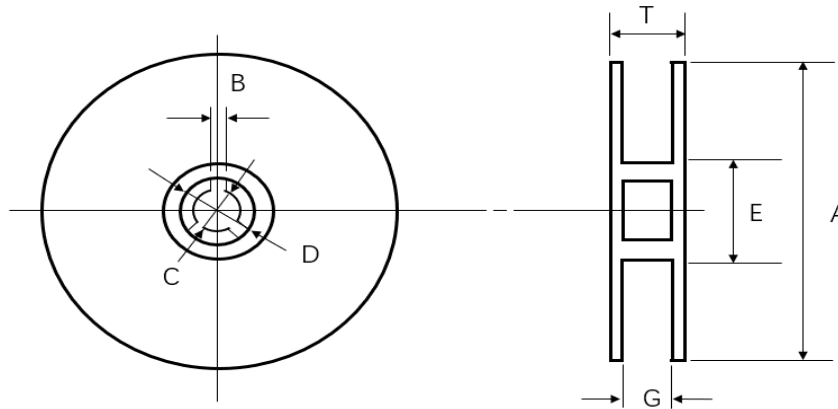
	01005 (0402)	0201 (0603)	0402 (1005)	0603 (1608)	0805 (2012)	1206 (3216)
P1	2.00±0.05(1.0 ±0.05)			4.00±0.10		
P0	4.00±0.10			4.00±0.10		
P2	2.00±0.05			2.00±0.05		
A	0.25±0.02	0.38±0.03	0.62±0.05	1.00±0.01	1.55±0.10	2.05±0.10
B	0.46±0.02	0.68±0.03	1.12±0.05	1.90±0.10	2.30±0.10	3.60±0.10
W	8.00±0.30			8.00±0.30		
E	1.75±0.10			1.75±0.10		
F	3.50±0.05			3.50±0.05		
D	φ1.50+0.10/-0.03			φ1.50+0.10/-0		
t	0.25±0.02	0.35±0.03	0.60±0.05	1.1Below		

2. Plastic Size



	0603 (1608)	0805 (2012)	1206 (3216)	1210 (3225)
P1	4±0.1	4±0.1	4±0.1	4±0.1
P0	4±0.1	4±0.1	4±0.1	4±0.1
P2	2±0.05	2±0.05	2±0.05	2±0.05
A	1.2±0.2	1.45±0.2	1.9±0.2	2.8±0.2
B	2.0±0.2	2.3±0.2	3.5±0.2	3.6±0.2
W	8±0.3	8±0.2	8±0.2	8±0.2
E	1.75±0.1	1.75±0.1	1.75±0.1	1.75±0.1
F	3.5±0.05	3.5±0.05	3.5±0.05	3.5±0.05
D	1.5 (+0.1/-0.0)	1.5 (+0.1/-0.0)	1.5 (+0.1/-0.0)	1.5 (+0.1/-0.0)
T1	1.4 max	2.5 max.	2.5 max.	2.5 max.
T2	0.25±0.1	0.305±0.1	0.30±0.1	0.30±0.1

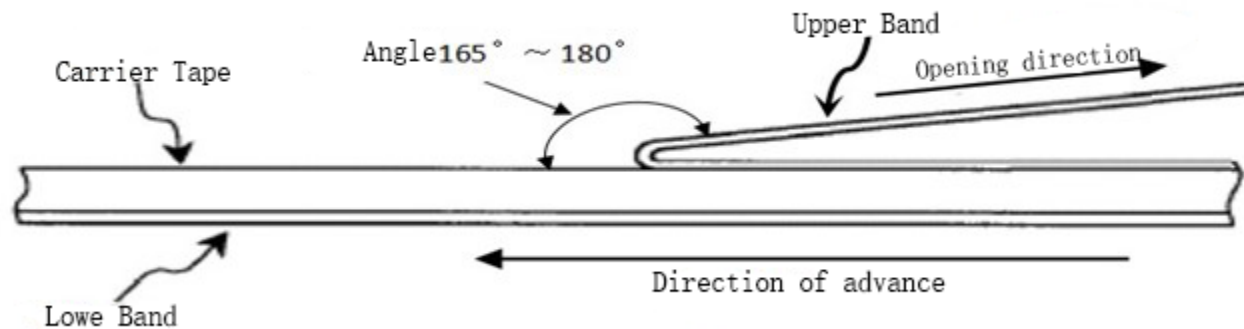
3. Disk Size



Disk Size	A (mm)	B (mm)	C (mm)	D (mm)	E (mm)	G (mm)	T (mm)
7"Reel	$\Phi 178 \pm 2.0$	2.0 ± 0.5	$\Phi 13 \pm 1.0$	$\Phi 21 \pm 0.8$	$\Phi 50$ or More	10 ± 1.0	13 ± 1.0

4. Instructions for use of reel tape

When the finished product is in use, the upper band (film) is at a speed of $300 \pm 10 \text{ mm/min}$, an Angle of $165^\circ \sim 180^\circ$ (as shown below), and the peeling strength is $0.1\text{N} \sim 0.7\text{N}$ ($10\text{g.f} \leq \text{peeling force} \leq 70\text{g.f}$).



Precautions for use

Multi-layer Ceramic Chip Capacitors (MLCC) may have short circuit or open circuit under the harsh working environment beyond the use frequency described in this letter of admission or related instructions, or under the action of external mechanical force overpressure. Or it may smoke, burn or even explode, so when using, we should first consider to follow the relevant instructions in this acknowledgement, if there is anything unclear, Plz contact our technical department, Quality Control Department or production Department.

1. The amount of solder used in welding

A. Too much solder will cause capacitor damage due to excessive pressure at the capacitor end.

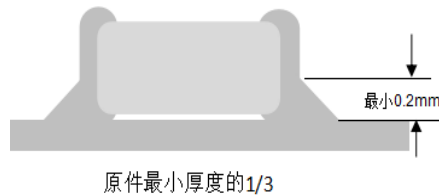


B. Too little solder fixed force is insufficient, may cause capacitor chip and line contact is poor.

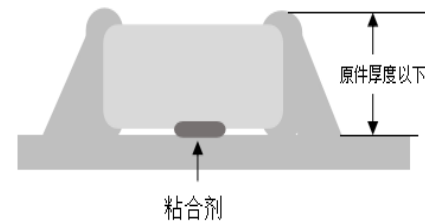


2. Recommended amount of solder:

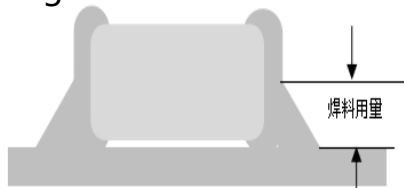
A. Optimal amount of solder for reflow welding



B. Optimum amount of solder for wave soldering

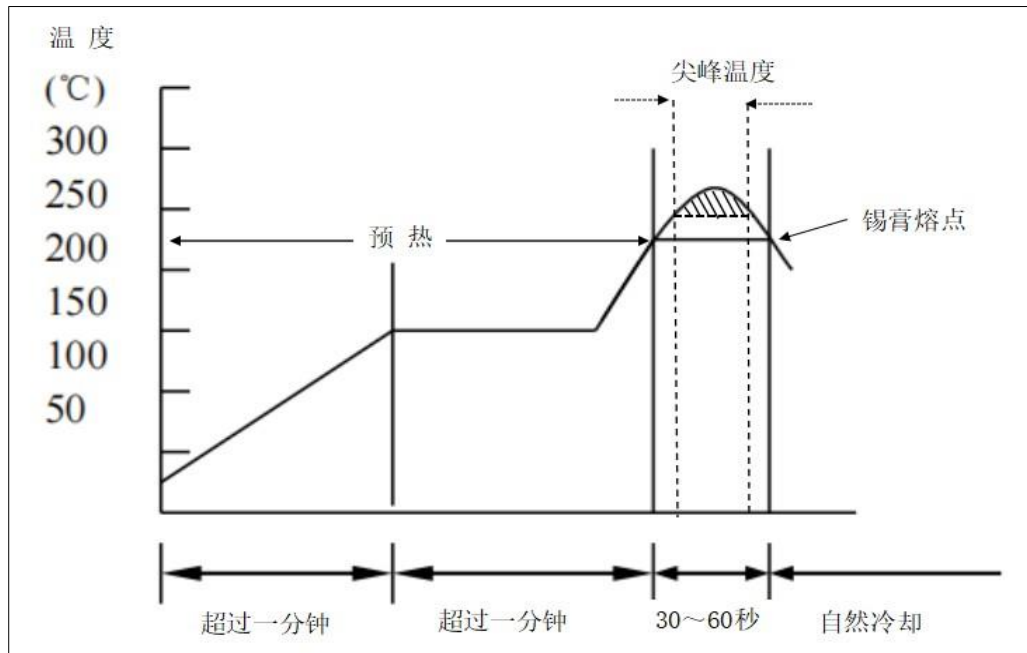


C. The optimal amount of solder used for repair with soldering iron



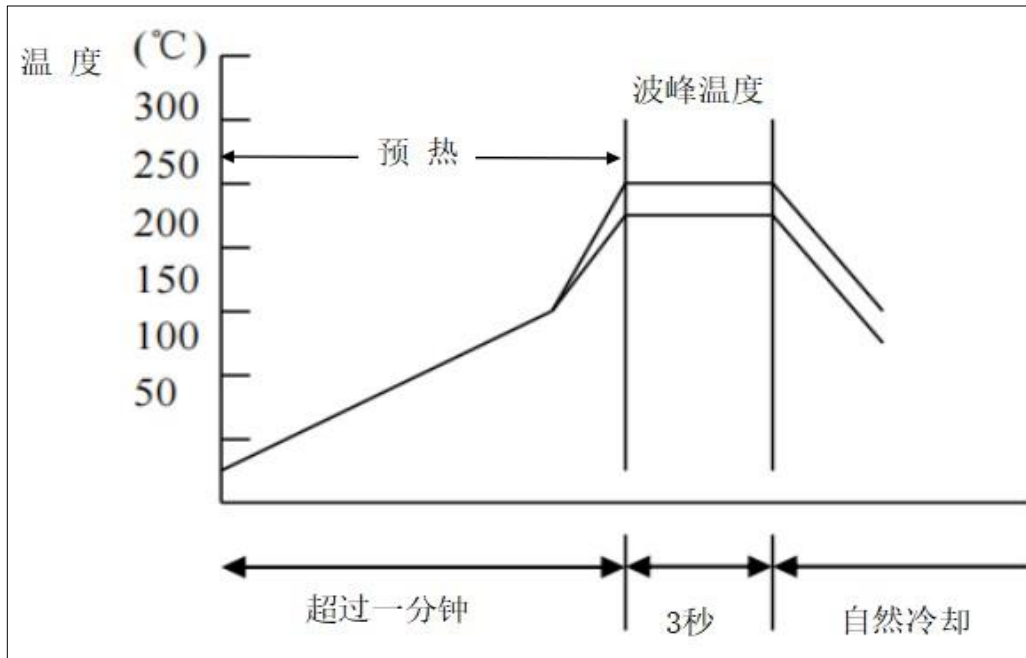
3.Recommended welding temperature curve:

Reflow welding



Solder type	Pb-Sn welding	Lead-free welding
Peak temperature	230°C ~ 250°C	240°C ~ 260°C
Peak time	3s ~ 10s	3s ~ 10s

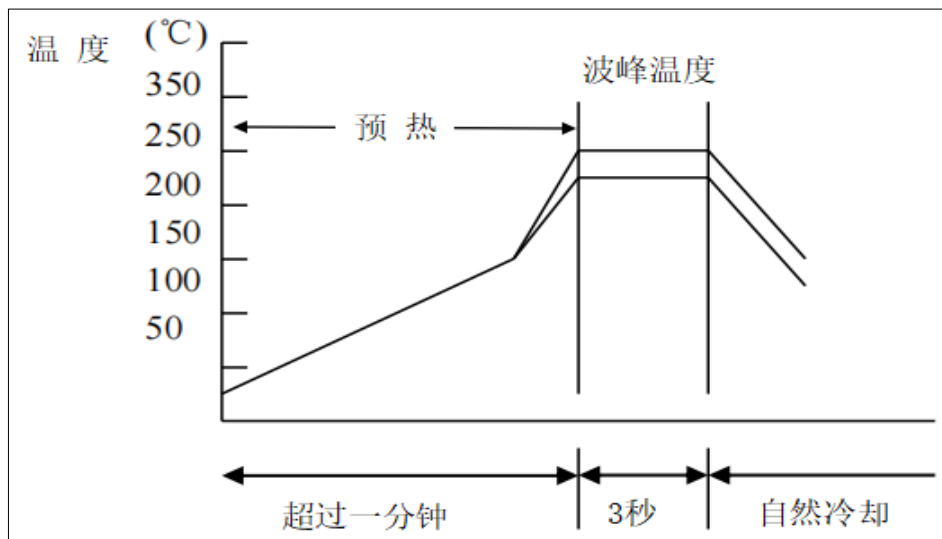
Wave soldering



Solder type	Pb-Sn welding	Lead-free welding
Peak temperature	230°C ~ 260°C	240°C ~ 270°C
Peak time	Within 3s	Within 3s

Hand welding

Manual welding is easy to cause micro-cracking or partial cracking of porcelain because of uneven local heating of capacitor. Therefore, the use of electric iron manual welding should be carefully operated, and the choice of the tip of the electric branding iron and tip temperature control should be more careful.



Preheat	Temperature	Power	Diameter	Time	Tin paste	Notice
$\Delta \leq 130^{\circ}\text{C}$	$\leq 350^{\circ}\text{C}$	$\leq 20\text{W}$	Recommended 1mm	$\leq 3\text{s}$	$\leq 1/2$ Capacitance height	Do not contact the iron head directly with the ceramic body

版本	修订日期	修订内容叙述
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